

mos field effect transistor $\mu PA622TT$

N-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

The $\mu \text{PA622TT}$ is a switching device which can be driven directly by a 4.0 V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as power switch of portable machine and so on.

FEATURES

- 4.0 V drive available
- · Low on-state resistance

 $R_{DS(on)1} = 82 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 10 \text{ V, ID} = 1.5 \text{ A)}$

 $R_{DS(on)2} = 120 \text{ m}\Omega \text{ MAX.} \text{ (Vgs} = 4.5 \text{ V, ID} = 1.0 \text{ A)}$

 $R_{DS(on)3} = 139 \text{ m}\Omega \text{ MAX.}$ (Vgs = 4.0 V, ID = 1.0 A)

ORDERING INFORMATION

| PART NUMBER | PACKAGE |
|-------------|-------------------|
| μPA622TT | 6 pin WSOF (1620) |

Marking: WC

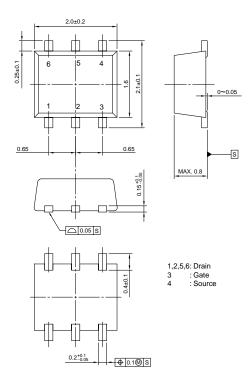
ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

| Drain to Source Voltage (Vgs = 0 V) | VDSS | 30 | V |
|--|--------------------|-------------|----|
| Gate to Source Voltage (Vps = 0 V) | Vgss | ±20 | V |
| Drain Current (DC) (T _A = 25°C) | I _{D(DC)} | ±3.0 | Α |
| Drain Current (pulse) Note1 | ID(pulse) | ±12 | Α |
| Total Power Dissipation | P _{T1} | 0.2 | W |
| Total Power Dissipation Note2 | P _{T2} | 1.3 | W |
| Channel Temperature | T_ch | 150 | °C |
| Storage Temperature | Tstg | -55 to +150 | °C |
| | | | |

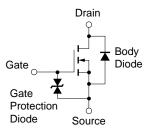
Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Mounted on FR-4 board of 5000 mm² x 1.1 mm, $t \le 5$ sec.

PACKAGE DRAWING (Unit: mm)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

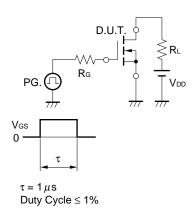
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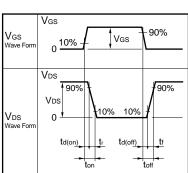


ELECTRICAL CHARACTERISTICS (TA = 25°C)

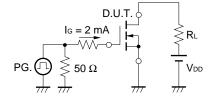
| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|---|------|------|------|------|
| Zero Gate Voltage Drain Current | Ipss | V _{DS} = 30 V, V _{GS} = 0 V | | | 10 | μΑ |
| Gate Leakage Current | Igss | Vgs = ±20 V, Vps = 0 V | | | ±10 | μΑ |
| Gate Cut-off Voltage | V _{GS(off)} | V _{DS} = 10 V, I _D = 1.0 mA | 1.5 | 2.0 | 2.5 | V |
| Forward Transfer Admittance | yfs | V _{DS} = 10 V, I _D = 1.5 A | 0.5 | 2.1 | | S |
| Drain to Source On-state Resistance | RDS(on)1 | Vgs = 10 V, ID = 1.5 A | | 65 | 82 | mΩ |
| | RDS(on)2 | Vgs = 4.5 V, ID = 1.0 A | | 90 | 120 | mΩ |
| | RDS(on)3 | Vgs = 4.0 V, ID = 1.0 A | | 104 | 139 | mΩ |
| Input Capacitance | Ciss | V _{DS} = 10 V | | 155 | | pF |
| Output Capacitance | Coss | V _G s = 0 V | | 45 | | pF |
| Reverse Transfer Capacitance | Crss | f = 1.0 MHz | | 27 | | pF |
| Turn-on Delay Time | td(on) | V _{DD} = 15 V, I _D = 1.5 A | | 10 | | ns |
| Rise Time | tr | Vgs = 10 V | | 28 | | ns |
| Turn-off Delay Time | t _{d(off)} | $R_G = 10 \Omega$ | | 75 | | ns |
| Fall Time | t f | | | 50 | | ns |
| Total Gate Charge | Q _G | V _{DD} = 24 V | | 3.8 | | nC |
| Gate to Source Charge | Qgs | Vgs = 10 V | | 0.7 | | nC |
| Gate to Drain Charge | Q _{GD} | ID = 3.0 A | | 1.3 | | nC |
| Body Diode Forward Voltage | V _{F(S-D)} | IF = 3.0 A, VGS = 0 V | | 0.90 | | V |

TEST CIRCUIT 1 SWITCHING TIME

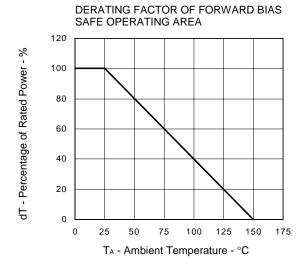


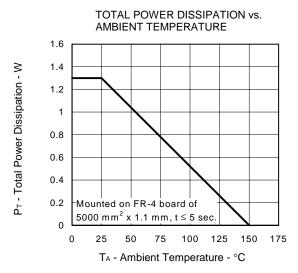


TEST CIRCUIT 2 GATE CHARGE

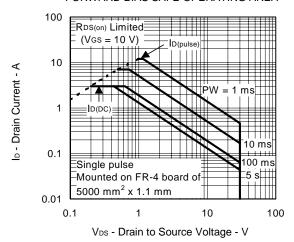


TYPICAL CHARACTERISTICS (TA = 25°C)

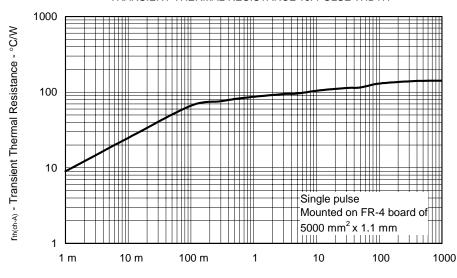




FORWARD BIAS SAFE OPERATING AREA



TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



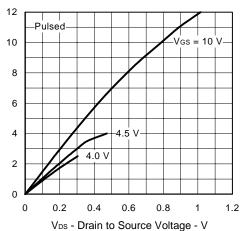
PW - Pulse Width - s

3

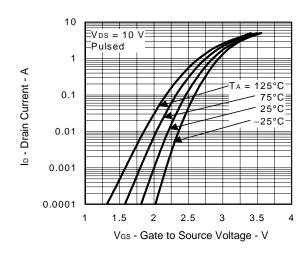
lo - Drain Current - A

VGS(off) - Gate Cut-off Voltage - V

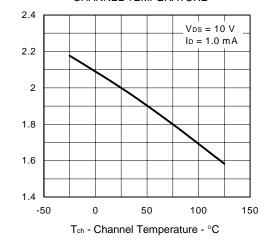
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



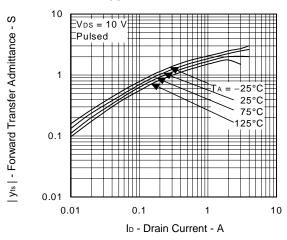
FORWARD TRANSFER CHARACTERISTICS



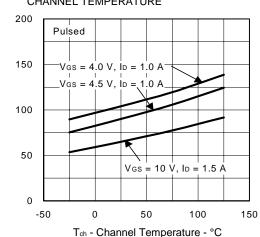
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



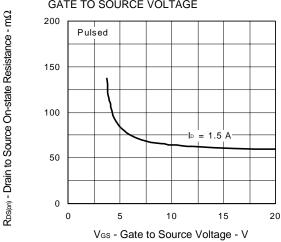
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



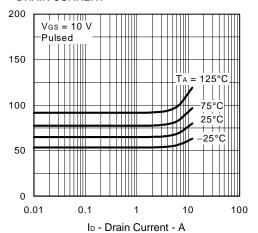
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



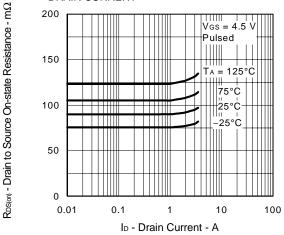
R_{DS(o1)} - Drain to Source On-state Resistance - mΩ

RDS(m) - Drain to Source On-state Resistance - m\Omega

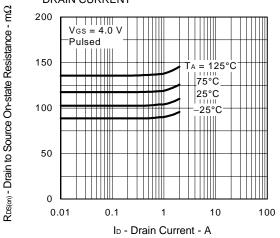
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



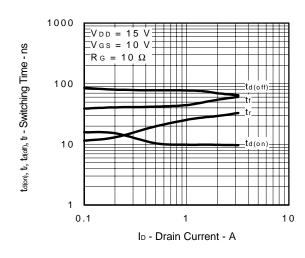
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



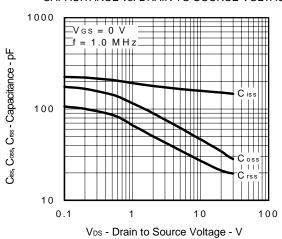
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



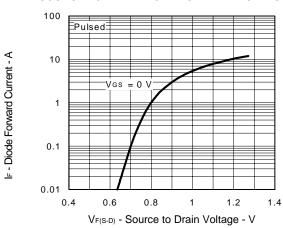
SWITCHING CHARACTERISTICS



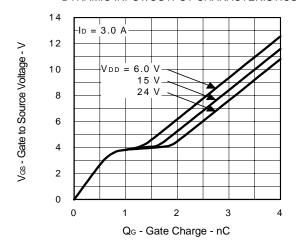
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



SOURCE TO DRAIN DIODE FORWARD VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



NEC μ PA622TT

[MEMO]

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